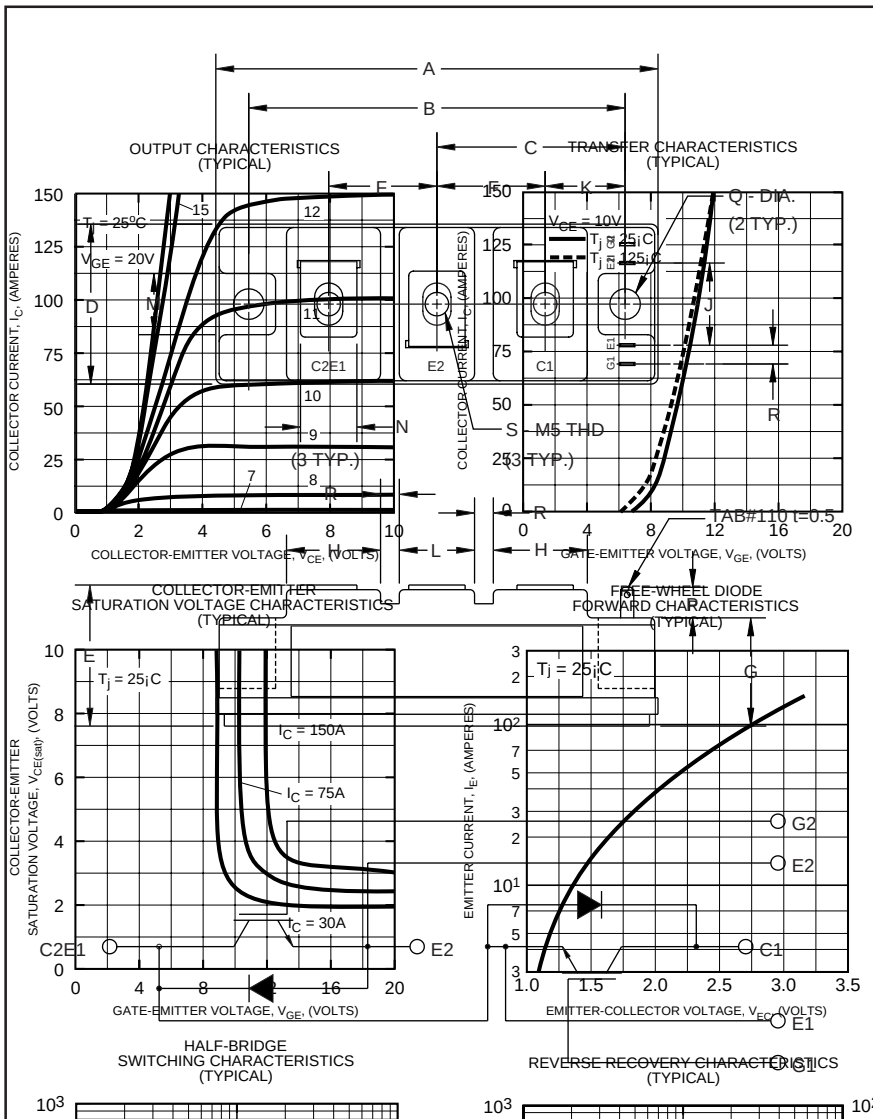


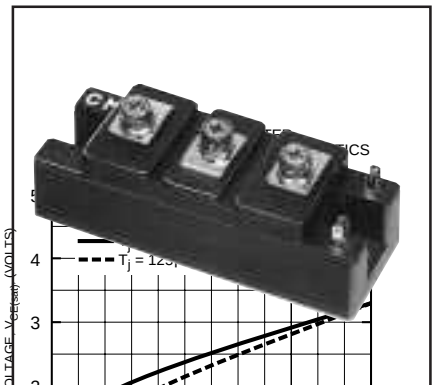
MITSUBISHI IGBT MODULES
CM75DY-24H
 HIGH POWER SWITCHING USE
 INSULATED TYPE



Outline Drawing and Circuit Diagram

Dimensions	Inches	Millimeters
A	3.70	94.0
B	3.15	80.0
C	1.57	40.0
D	1.34	34.0
E	1.34	34.0
F	0.90	23.0
G	0.95	24.1
H	0.79	20.0
J	0.71	18.0

Dimensions	Inches	Millimeters
K	0.67	17.0
L	0.63	16.0
M	0.51	13.0
N	0.47	12.0
P	0.256 Dia.	6.5
Q	0.16	4.0
R	0.16	4.0
S	M5 Metric	M5



Description:

Mitsubishi IGBT Modules are designed for use in switching applications. Each module consists of two IGBT's in a half bridge configuration with each transistor having a reverse-connected super-fast recovery free-wheel diode. All components and interconnects are isolated from the heat sinking baseplate, offering simplified system assembly and thermal management.

Features:

- Low Drive Power
- Low $V_{CE(sat)}$
- Discrete Super Fast Recovery Free-Wheel Diode
- High Frequency Operation
- Isolated Baseplate for Easy Heat Sinking

Applications:

- AC Motor Control
- Motion/Servo Control
- UPS
- Welding Power Supplies

Ordering Information:

Example: Select the complete part module number you desire from the table below - i.e. CM75DY-24H is a 1200V (V_{CES}), 75 Ampere Dual IGBT Module.

Type	Current Rating Amperes	V_{CES} Volts (x 50)
CM	75	24

CM75DY-24H

**HIGH POWER SWITCHING USE
INSULATED TYPE**

Absolute Maximum Ratings, $T_j = 25^\circ\text{C}$ unless otherwise specified

	Symbol	Ratings	Units
Junction Temperature	T_j	-40 to 150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-40 to 125	$^\circ\text{C}$
Collector-Emitter Voltage (V _{CE}) (E-Short)	V_{CES}	1200	Volts
Gate-Emitter Voltage (V _{GE}) (E-Short)	V_{GES}	± 20	Volts
Collector Current (I _C)	I_C	75	Amperes
Peak Collector Current (I _{CM})	I_{CM}	150*	Amperes
Emitter Current (I _E)	I_E	75	Amperes
Peak Emitter Current (I _{EM})	I_{EM}	150*	Amperes
Maximum Collector Dissipation (P _C) (T _C = 25 $^\circ\text{C}$, T _j $\leq 50^\circ\text{C}$)	P_C	600	Watts
Mounting Torque, M5 Mounting		1.47 ~ 1.96	N · m
Mounting Torque, M6 Mounting		1.96 ~ 2.94	N · m
Weight		190	Grams
Isolation Voltage (Main Terminal to Baseplate, AC 1 min.)	V_{ISO}	2500	Vrms

*Pulse width and repetition rate should be such that the device junction temperature (T_j) does not exceed $T_{j(\text{max})}$ rating.

**Represents characteristics of the anti-parallel, emitter-to-collector free-wheel diode (FWDi).

Static Electrical Characteristics, $T_j = 25^\circ\text{C}$ unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Collector-Cutoff Current	I_{CES}	$V_{\text{CE}} = V_{\text{CES}}, V_{\text{GE}} = 0\text{V}$	—	—	1.0	mA
Gate Leakage Current	I_{GES}	$V_{\text{GE}} = V_{\text{GES}}, V_{\text{CE}} = 0\text{V}$	—	—	0.5	μA
Gate-Emitter Threshold Voltage	$V_{\text{GE(th)}}$	$I_C = 7.5\text{mA}, V_{\text{CE}} = 10\text{V}$	4.5	6.0	7.5	Volts
Collector-Emitter Saturation Voltage	$V_{\text{CE(sat)}}$	$I_C = 75\text{A}, V_{\text{GE}} = 15\text{V}$	—	2.5	3.4**	Volts
		$I_C = 75\text{A}, V_{\text{GE}} = 15\text{V}, T_j = 150^\circ\text{C}$	—	2.25	—	Volts
Total Gate Charge	Q_G	$V_{\text{CC}} = 600\text{V}, I_C = 75\text{A}, V_{\text{GE}} = 15\text{V}$	—	375	—	nC
Emitter-Collector Voltage	V_{EC}	$I_E = 75\text{A}, V_{\text{GE}} = 0\text{V}$	—	—	3.5	Volts

** Pulse width and repetition rate should be such that device junction temperature rise is negligible.

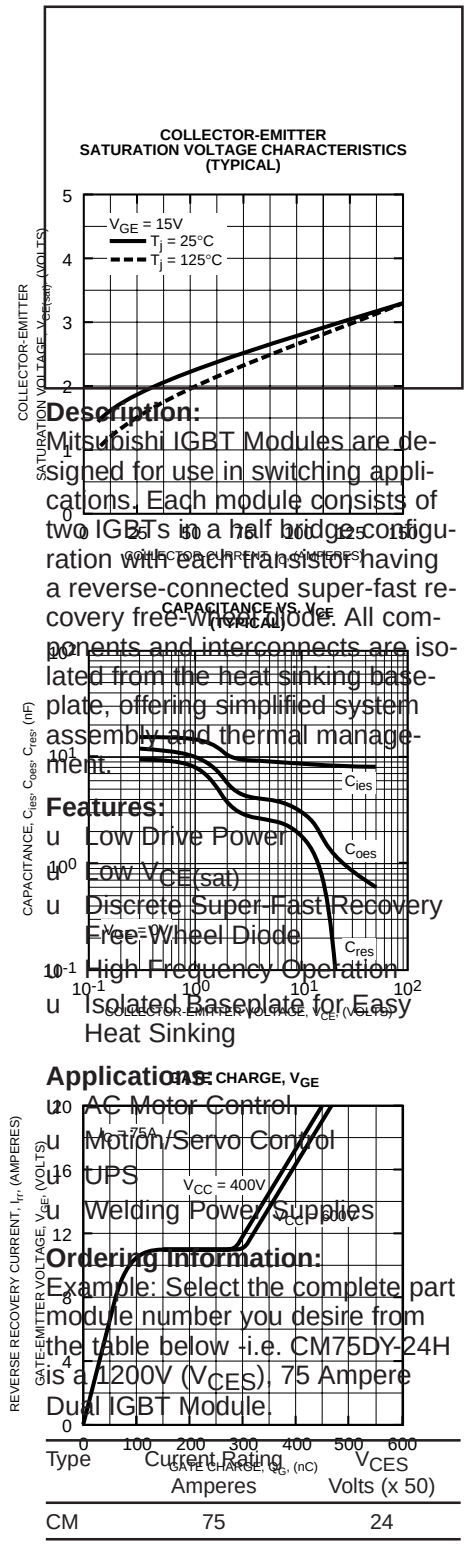
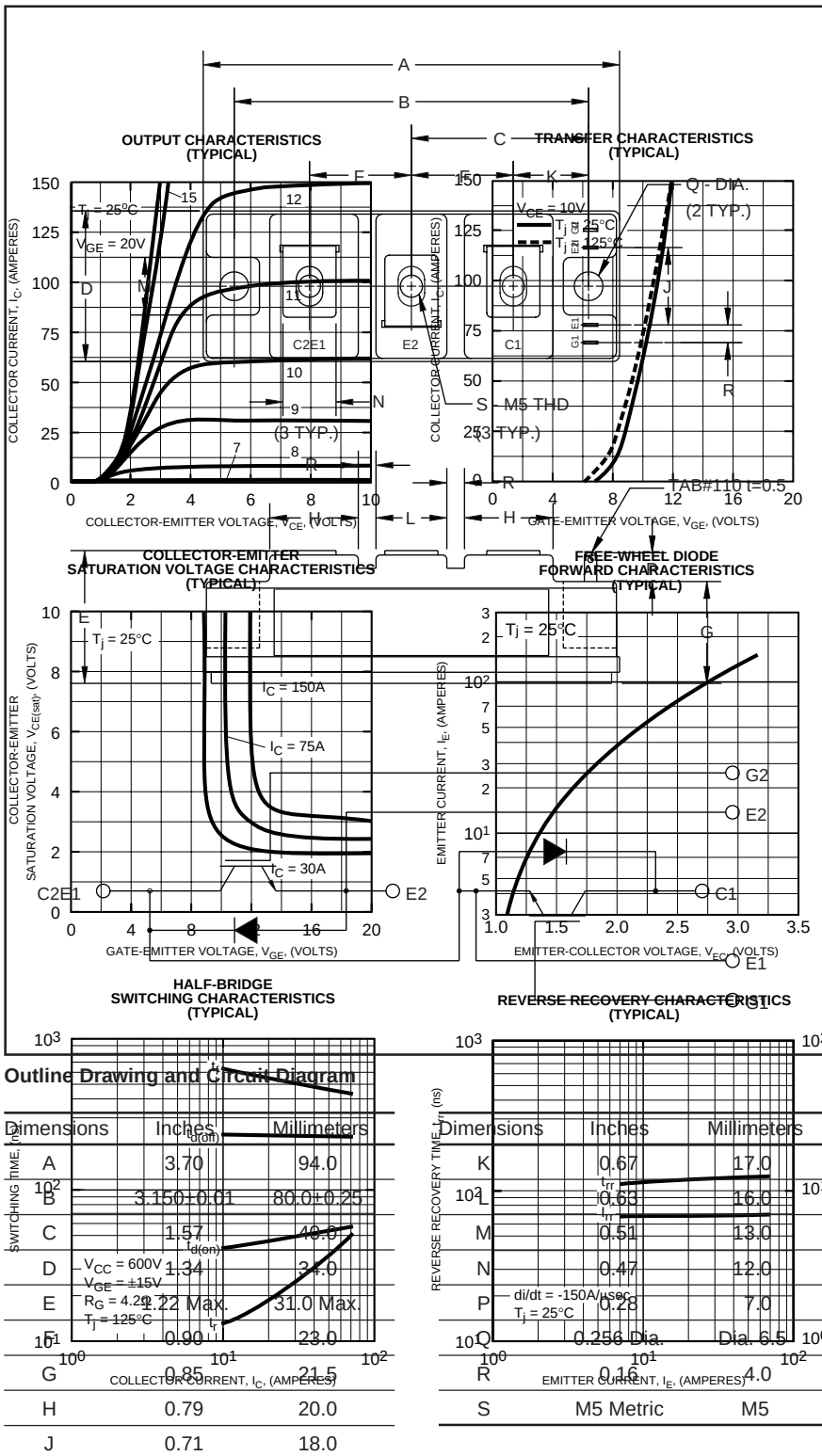
Dynamic Electrical Characteristics, $T_j = 25^\circ\text{C}$ unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Input Capacitance	C_{ies}		—	—	15	nF
Output Capacitance	C_{oes}	$V_{\text{GE}} = 0\text{V}, V_{\text{CE}} = 10\text{V}$	—	—	5.3	nF
Reverse Transfer Capacitance	C_{res}		—	—	3	nF
Resistive	Turn-on Delay Time	$t_{\text{d(on)}}$	—	—	150	ns
Load	Rise Time	t_r	—	—	350	ns
Switching	Turn-off Delay Time	$t_{\text{d(off)}}$	—	—	250	ns
Times	Fall Time	t_f	—	—	350	ns
Diode Reverse Recovery Time	t_{rr}	$I_E = 75\text{A}, di_E/dt = -150\text{A}/\mu\text{s}$	—	—	250	ns
Diode Reverse Recovery Charge	Q_{rr}	$I_E = 75\text{A}, di_E/dt = -150\text{A}/\mu\text{s}$	—	0.56	—	μC

Thermal and Mechanical Characteristics, $T_j = 25^\circ\text{C}$ unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Thermal Resistance, Junction to Case	$R_{\text{th(j-c)}}$	Per IGBT	—	—	0.21	$^\circ\text{C}/\text{W}$
Thermal Resistance, Junction to Case	$R_{\text{th(j-c)}}$	Per FWDi	—	—	0.47	$^\circ\text{C}/\text{W}$
Contact Thermal Resistance	$R_{\text{th(c-f)}}$	Per Module, Thermal Grease Applied	—	—	0.075	$^\circ\text{C}/\text{W}$

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CM75DY-24H
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**HIGH POWER SWITCHING USE
INSULATED TYPE**

Absolute Maximum Ratings, $T_j = 25^\circ\text{C}$ unless otherwise specified

	Symbol	Ratings	Units
Junction Temperature	T_j	-40 to 150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-40 to 125	$^\circ\text{C}$
Collector-Emitter Voltage (V _{CE}) (V _{CE} = 0V)	V_{CES}	1200	Volts
Gate-Emitter Voltage (V _{GE}) (V _{GE} = 0V)	V_{GES}	± 20	Volts
Collector Current (I _C) (I _C = 25 $^\circ\text{C}$)	I_C	75	Amperes
Peak Collector Current (I _{CM}) (I _{CM} = 25 $^\circ\text{C}$)	I_{CM}	150*	Amperes
Emitter Current (I _E) (I _E = 25 $^\circ\text{C}$)	I_E	75	Amperes
Peak Emitter Current (I _{EM}) (I _{EM} = 25 $^\circ\text{C}$)	I_{EM}	150*	Amperes
Maximum Collector Dissipation (P _C) (T _C = 25 $^\circ\text{C}$, T _j = 50 $^\circ\text{C}$)	P_C	600	Watts
Mounting Torque, M5 Mounting		1.47 ~ 1.96	N · m
Mounting Torque, M6 Mounting		1.96 ~ 2.94	N · m
Weight		190	Grams
Isolation Voltage (Main Terminal to Baseplate, AC 1 min.)	V_{ISO}	2500	V _{rms}

*Pulse width and repetition rate should be such that the device junction temperature (T_j) does not exceed $T_{j(\text{max})}$ rating.

**Represents characteristics of the anti-parallel, emitter-to-collector free-wheel diode (FWDi).

Static Electrical Characteristics, $T_j = 25^\circ\text{C}$ unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Collector-Cutoff Current	I_{CES}	$V_{\text{CE}} = V_{\text{CES}}, V_{\text{GE}} = 0\text{V}$	—	—	1.0	mA
Gate Leakage Current	I_{GES}	$V_{\text{GE}} = V_{\text{GES}}, V_{\text{CE}} = 0\text{V}$	—	—	0.5	mA
Gate-Emitter Threshold Voltage	$V_{\text{GE(th)}}$	$I_C = 7.5\text{mA}, V_{\text{CE}} = 10\text{V}$	4.5	6.0	7.5	Volts
Collector-Emitter Saturation Voltage	$V_{\text{CE(sat)}}$	$I_C = 75\text{A}, V_{\text{GE}} = 15\text{V}$	—	2.5	3.4**	Volts
		$I_C = 75\text{A}, V_{\text{GE}} = 15\text{V}, T_j = 150^\circ\text{C}$	—	2.25	—	Volts
Total Gate Charge	Q_G	$V_{\text{CC}} = 600\text{V}, I_C = 75\text{A}, V_{\text{GE}} = 15\text{V}$	—	375	—	nC
Emitter-Collector Voltage	V_{EC}	$I_E = 75\text{A}, V_{\text{GE}} = 0\text{V}$	—	—	3.5	Volts

** Pulse width and repetition rate should be such that device junction temperature rise is negligible.

Dynamic Electrical Characteristics, $T_j = 25^\circ\text{C}$ unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Input Capacitance	C_{ies}		—	—	15	nF
Output Capacitance	C_{oes}	$V_{\text{GE}} = 0\text{V}, V_{\text{CE}} = 10\text{V}$	—	—	5.3	nF
Reverse Transfer Capacitance	C_{res}		—	—	3	nF
Resistive	Turn-on Delay Time	$t_{\text{d(on)}}$	—	—	150	ns
Load	Rise Time	t_r	—	—	350	ns
Switching	Turn-off Delay Time	$t_{\text{d(off)}}$	—	—	250	ns
Times	Fall Time	t_f	—	—	350	ns
Diode Reverse Recovery Time	t_{rr}	$I_E = 75\text{A}, dI_E/dt = -150\text{A/n}\bar{s}$	—	—	250	ns
Diode Reverse Recovery Charge	Q_{rr}	$I_E = 75\text{A}, dI_E/dt = -150\text{A/n}\bar{s}$	—	0.56	—	mC

Thermal and Mechanical Characteristics, $T_j = 25^\circ\text{C}$ unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Thermal Resistance, Junction to Case	$R_{\text{th(j-c)}}$	Per IGBT	—	—	0.21	$^\circ\text{C/W}$
Thermal Resistance, Junction to Case	$R_{\text{th(j-c)}}$	Per FWDi	—	—	0.47	$^\circ\text{C/W}$
Contact Thermal Resistance	$R_{\text{th(c-f)}}$	Per Module, Thermal Grease Applied	—	—	0.075	$^\circ\text{C/W}$